LIST OF REFERENCES CITED BY APPLICANT						ATTY. DOCKET NO.:	APPLICATION NO.:					
						85170-5100	10 773 696					
						APPLICANT:						
	•	(Use several sheets if no	ecessary)		Mervyn, John ROSE et al.							
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U.S. PATENT DOCUMENTS												
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	ļ. <u>.</u>	NAME		CLASS	SUBCLASS	FILING DATE IP APPROPRIATE			
XX	AA	6,451,631 B1	9/2002	Gri	Grigoropoulos et al.		438	149				
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	AC											
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FOREIGN PATENT DOCUMENTS												
		DOCUMENT NUMBER		DATE		COUNTRY		SUBCLASS	TRANSLATION			
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Lu	AF	EP 1 094 485		001	Europe				x			
N	AG	EP 1 047 095		2000	Europe				х			
Xh	AH	JP 2002110544 w/ English Abstract		002	Japan				х			
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		OTHER REF	ERENCES	(Includii	ng Author, Ti	tle, Date, Pertinent Pages, Etc.)	·	L			
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.												
		in conformance and not	considered.	include	copy of this	torm with next communication	to application	ant.				

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LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary)							85170-5100	10/773,696				
							Mervyn John ROSE et al.					
						FILING DATE:	-	GROUP:				
				U.S.	PATE	NT DOCU	February 6, 2004		2813			
*EXAMINER INITIAL	٨	DOCUMENT NUMBER	DATE			NAME	CLASS	SUBÇLASS	FILING DA	ATE IF		
A	AA	5,090,932	2/1992		Dieumegard		et al.	445	24	 		
()	AB	5,094,975	3/1992		Siu			437	89			
ZU	AC	5,804,910	9/1998		Tjaden et al.		313	310				
	AD											
	AE											
	L		F	ORE	IGN PA	ATENT DOC	UMENTS		·		_	
								CLASS	SUBCLASS	TRANSLA	TION	
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Xh	AF	EP 0 726 589 AI 8		8/1996		Europe				х		
1/	AG	EP 0 578 428		1/1994		PCT				x		
Xh	АН	JP 7073800 W/ English Abstract		3/1995		Japan				х		
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